Bipolar NPN Transistor

High Speed, High Gain Bipolar NPN Power Transistor with Integrated Collector-Emitter Diode and Built-In Efficient Antisaturation Network

The MJD18002D2 is a state-of-the-art high speed, high gain bipolar transistor (H2BIP). Tight dynamic characteristics and lot to lot minimum spread (± 150 ns on storage time) make it ideally suitable for light ballast applications. Therefore, there is no longer a need to guarantee an $h_{\rm FE}$ window.

Features

- Low Base Drive Requirement
- High Peak DC Current Gain (55 Typical) @ I_C = 100 mA
- Extremely Low Storage Time Min/Max Guarantees Due to the H2BIP Structure which Minimizes the Spread
- Integrated Collector-Emitter Free Wheeling Diode
- Fully Characterized and Guaranteed Dynamic V_{CEsat}
- Characteristics Make It Suitable for PFC Application
- Epoxy Meets UL 94 V-0 @ 0.125 in
- ESD Ratings: Human Body Model, 3B > 8000 V
 Machine Model, C > 400 V
- Six Sigma® Process Providing Tight and Reproductible Parameter Spreads
- Pb-Free Package is Available

MAXIMUM RATINGS

F	Symbol	Value	Unit	
Collector-Emitter S	V_{CEO}	450	Vdc	
Collector-Base Bre	V_{CBO}	1000	Vdc	
Collector-Emitter E	V _{CES}	1000	Vdc	
Emitter-Base Volta	V _{EBO}	11	Vdc	
Collector Current	- Continuous - Peak (Note 1)	I _C	2.0 5.0	Adc
Base Current	ContinuousPeak (Note 1)	I _B I _{BM}	1.0 2.0	Adc

THERMAL CHARACTERISTICS

Characteristic	Symbol	Value	Unit
Total Device Dissipation @ T _C = 25°C Derate above 25°C	P _D	50 0.4	W W/°C
Operating and Storage Temperature Range	T _J , T _{stg}	-65 to +150	°C
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	5.0	°C/W
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	71.4	°C/W
Maximum Lead Temperature for Soldering Purposes: 1/8" from Case for 5 seconds	T _L	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

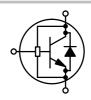
1. Pulse Test: Pulse Width = 5.0 ms, Duty Cycle = 10%.



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POWER TRANSISTOR 2 AMPERES 1000 VOLTS, 50 WATTS





DPAK CASE 369C STYLE 1

MARKING DIAGRAM



Y = Year
WW = Work Week
18002D2 = Device Code
G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping [†]
MJD18002D2T4	DPAK	3000/Tape & Reel
MJD18002D2T4G	DPAK (Pb-Free)	3000/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic				Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS				•	•	•	•	•
Collector–Emitter Sustaining Voltage (I _C = 100 mA, L = 25 mH)			V _{CEO(sus)}	450	570	_	Vdc	
Collector-Base Breakdown Voltage (I _{CBO} = 1 mA)			V _{CBO}	1000	1100	_	Vdc	
Emitter-Base Breakdown Voltage (I _{EB}	_O = 1 mA)			V _{EBO}	11	14	-	Vdc
Collector Cutoff Current (V _{CE} = Rated	V _{CEO} , I _B = 0)			I _{CEO}	_	-	100	μAdc
Collector Cutoff Current (V _{CE} = Rated V _{CES} , V _{EB} = 0) $(V_{CF} = 500 \text{ V}, V_{FB} = 0)$			@ T _C = 25°C @ T _C = 125°C @ T _C = 125°C	I _{CES}	- - -	- - -	100 500 100	μAdc
Emitter–Cutoff Current (V _{EB} = 10 Vdc,	Ic = 0)			I _{EBO}	_	_	500	μAdc
ON CHARACTERISTICS	-0 -/			·LBO	Į.	1		P
Base–Emitter Saturation Voltage (I_C = 0.4 Adc, I_B = 40 mAdc) (I_C = 1.0 Adc, I_B = 0.2 Adc)			@ T _C = 25°C @ T _C = 25°C	V _{BE(sat)}	- -	0.78 0.87	1.0 1.1	Vdc
Collector–Emitter Saturation Voltage $(I_C = 0.4 \text{ Adc}, I_B = 40 \text{ mAdc})$			@ T _C = 25°C @ T _C = 125°C	V _{CE(sat)}	- -	0.36 0.50	0.6 1.0	Vdc
$(I_C = 1.0 \text{ Adc}, I_B = 0.2 \text{ Adc})$			@ T _C = 25°C @ T _C = 125°C		- -	0.40 0.65	0.75 1.2	
DC Current Gain (I _C = 0.4 Adc, V _{CE} = 1.0 Vdc)			@ T _C = 25°C @ T _C = 125°C	h _{FE}	14 8.0	25 15	- -	-
$(I_C = 1.0 \text{ Adc}, V_{CE} = 1.0 \text{ Vdc})$			@ T _C = 25°C @ T _C = 125°C		6.0 4.0	10 6.0	- -	
DYNAMIC CHARACTERISTICS			ı	•	I.	•	•	•
Current Gain Bandwidth (I _C = 0.5 Adc, V _{CE} = 10 Vdc, f = 1 MHz)				f _t	-	13	-	MHz
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f = 1 MHz)				C _{ob}	-	50	100	pF
Input Capacitance (V _{EB} = 8 Vdc)				C _{ib}	-	340	500	pF
DIODE CHARACTERISTICS								
Forward Diode Voltage (I _{EC} = 1.0 Adc) (I _{EC} = 0.4 Adc)		@ T _C = 25°C	V _{EC}	-	1.2	1.5	Vdc	
		@ T _C = 25°C		_	1.0	1.3		
			@ T _C = 125°C		_	0.6	-	
Forward Recovery Time (I _F = 0.4 Adc, di/dt = 10 A/μs)			@ T _C = 25°C	t _{fr}	-	517	-	ns
$(I_F = 1.0 \text{ Adc, di/dt} = 10 \text{ A/}\mu\text{s})$			@ T _C = 25°C		_	480	-	
DYNAMIC SATURATION VOLTAGE								
	I _C = 0.4 Adc	@ 1 μs	@ T _C = 25°C	V _{CE(dsat)}	-	7.4	_	V
Dynamic Saturation Voltage Determinated 1 μs and 3 μs	I _{B1} = 40 mA V _{CC} = 300 Vdc	@ 3 μs	@ T _C = 25°C	1	-	2.5	-	
respectively after rising I _{B1} reaches 90% of final I _{B1}	I _C = 1 Adc	@ 1 μs	@ T _C = 25°C		-	11.7	-	
	$I_{B1} = 0.2 \text{ A}$ $V_{CC} = 300 \text{ Vdc}$	@ 3 μs	@ T _C = 25°C	1	-	1.3	-	1

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic				Min	Тур	Max	Unit
SWITCHING CHARACTER	RISTICS: Resistive Load (D.C.S. 10%,	Pulse Width = 40 μs	s)		•	•	
Turn-on Time	I _C = 0.4 Adc, I _{B1} = 40 mAdc	@ T _C = 25°C @ T _C = 125°C	t _{on}	- -	225 375	350 -	ns
Turn-off Time	$I_{B2} = 200 \text{ mAdc}$ $V_{CC} = 300 \text{ Vdc}$	@ T _C = 25°C @ T _C = 125°C	t _{off}	0.8	_ 1.5	1.1 -	μs
Turn-on Time	I _C = 1.0 Adc, I _{B1} = 0.2 Adc	@ T _C = 25°C @ T _C = 125°C	t _{on}	-	100 94	150 -	ns
Turn-off Time	$I_{B2} = 0.5 \text{ Adc}$ $V_{CC} = 300 \text{ Vdc}$	@ T _C = 25°C @ T _C = 125°C	t _{off}	0.95 -	_ 1.5	1.25 -	μs
SWITCHING CHARACTER	RISTICS: Inductive Load (V _{clamp} = 300	V, V _{CC} = 15 V, L = 2	200 μH)				
Fall Time		@ T _C = 25°C @ T _C = 125°C	t _f	- -	130 120	175 -	ns
Storage Time	$I_{C} = 0.4 \text{ Adc}$ $I_{B1} = 40 \text{ mAdc}$ $I_{B2} = 0.2 \text{ Adc}$	@ T _C = 25°C @ T _C = 125°C	t _s	0.4	_ 0.7	0.7 -	μs
Cross-over Time	.62 0.27.00	@ T _C = 25°C @ T _C = 125°C	t _c	- -	110 100	175 -	ns
Fall Time		@ T _C = 25°C @ T _C = 125°C	t _f	- -	130 140	175 -	ns
Storage Time	$I_C = 0.8 \text{ Adc}$ $I_{B1} = 160 \text{ mAdc}$ $I_{B2} = 160 \text{ mAdc}$	@ T _C = 25°C @ T _C = 125°C	t _s	2.1 -	3.0	2.4 -	μs
Cross-over Time		@ T _C = 25°C @ T _C = 125°C	t _c	- -	275 350	350 -	ns
Fall Time		@ T _C = 25°C @ T _C = 125°C	t _f	- -	100 100	150 -	ns
Storage Time	$I_C = 1.0 \text{ Adc}$ $I_{B1} = 0.2 \text{ Adc}$ $I_{B2} = 0.5 \text{ Adc}$	@ T _C = 25°C @ T _C = 125°C	t _s	- -	1.05 1.45	1.2 -	μS
Cross-over Time		@ T _C = 25°C @ T _C = 125°C	t _c	_ _	100 115	150 -	ns

TYPICAL STATIC CHARACTERISTICS

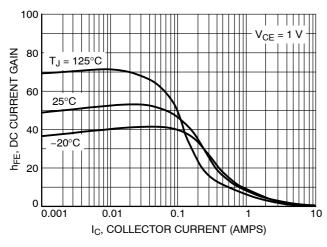


Figure 1. DC Current Gain @ 1 V

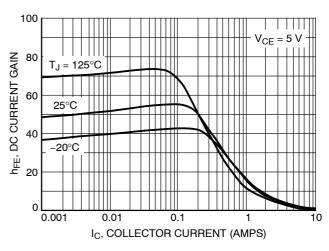


Figure 2. DC Current Gain @ 5 V

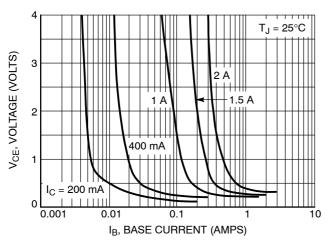


Figure 3. Collector Saturation Region

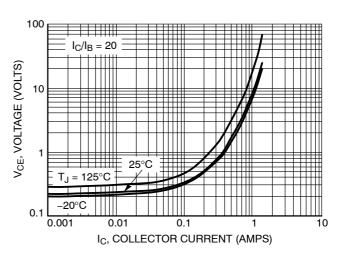


Figure 4. Collector-Emitter Saturation Voltage

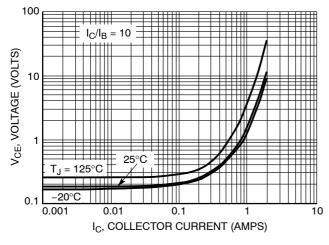


Figure 5. Collector-Emitter Saturation Voltage

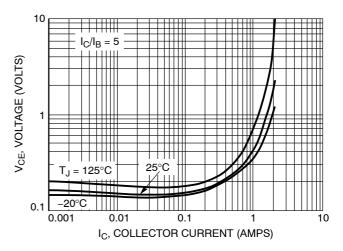


Figure 6. Collector-Emitter Saturation Voltage

TYPICAL STATIC CHARACTERISTICS

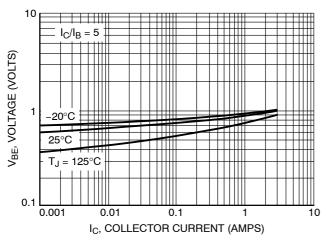


Figure 7. Base–Emitter Saturation Region $I_C/I_B = 5$

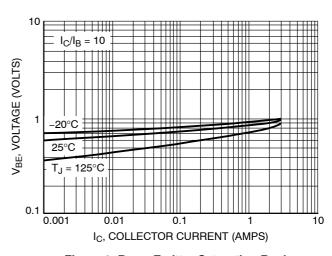


Figure 8. Base–Emitter Saturation Region $I_C/I_B = 10$

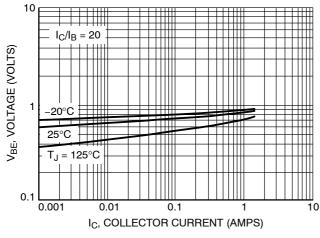


Figure 9. Base–Emitter Saturation Region $I_C/I_B = 20$

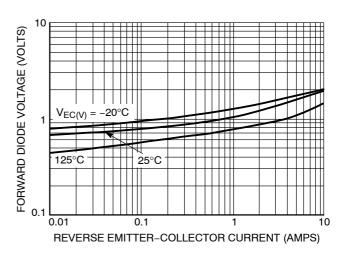


Figure 10. Forward Diode Voltage

TYPICAL SWITCHING CHARACTERISTICS

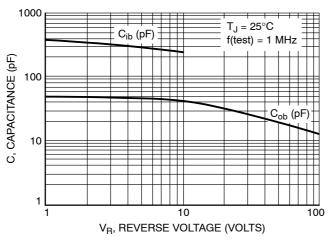


Figure 11. Capacitance

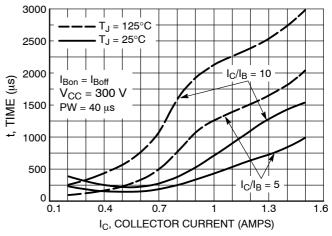


Figure 12. Resistive Switch Time, ton

TYPICAL SWITCHING CHARACTERISTICS

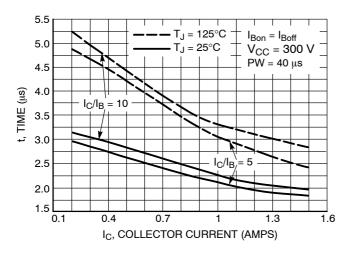


Figure 13. Resistive Switch Time, toff

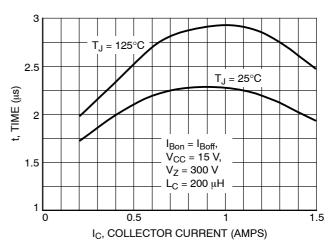


Figure 14. Inductive Storage Time, t_{si} @ I_C/I_B = 5

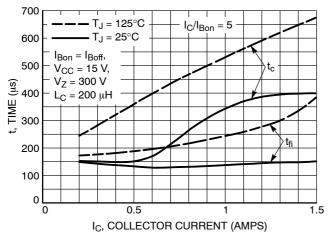


Figure 15. Inductive Switching, $t_c \& t_{fi} @ I_C/I_B = 5$

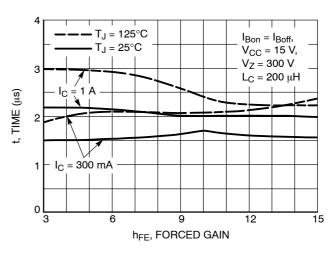


Figure 16. Inductive Storage Time

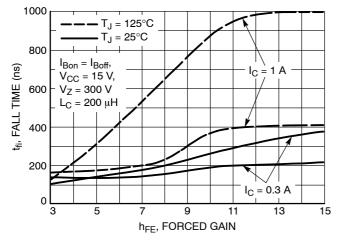


Figure 17. Inductive Fall Time

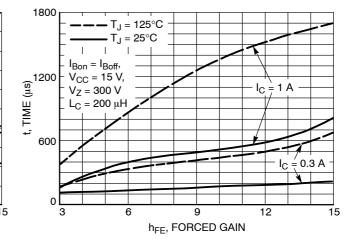


Figure 18. Inductive Cross-Over Time

TYPICAL SWITCHING CHARACTERISTICS

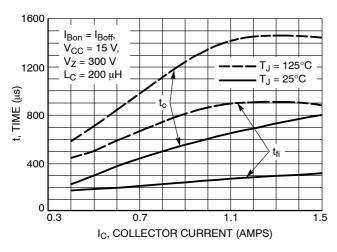


Figure 19. Inductive Switching Time, $t_{\rm fi}$ & $T_{\rm C}$ @ G = 10

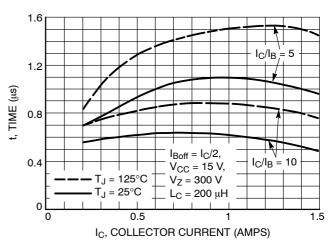


Figure 20. Inductive Switching Time, tsi

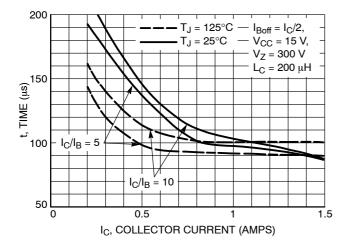


Figure 21. Inductive Storage Time, tfi

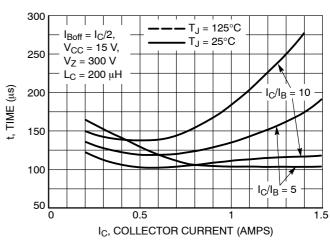


Figure 22. Inductive Storage Time, t_c

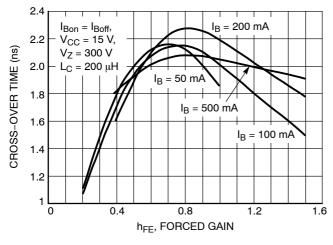


Figure 23. Inductive Storage Time, tsi

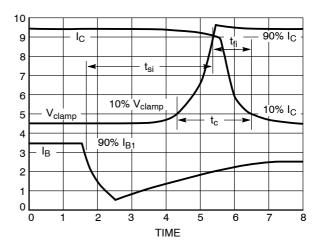


Figure 24. Inductive Switching Measurements

Figure 25. Inductive Load Switching Drive Circuit

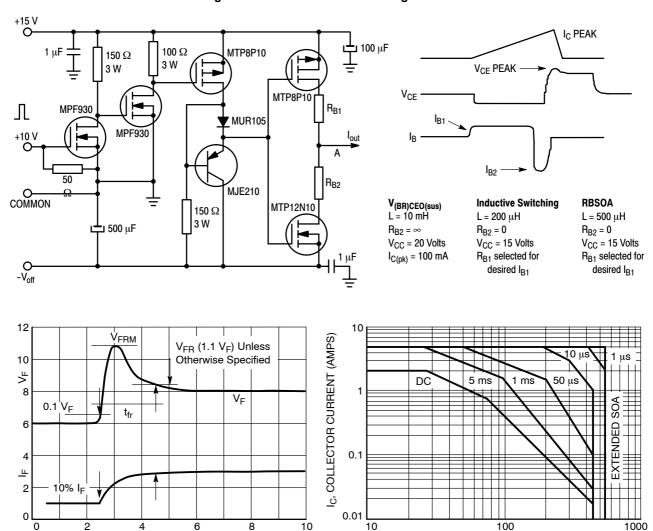


Figure 26. t_{fr} Measurement

Figure 27. Forward Bias Safe Operating Area

V_{CF}, COLLECTOR-EMITTER VOLTAGE (VOLTS)

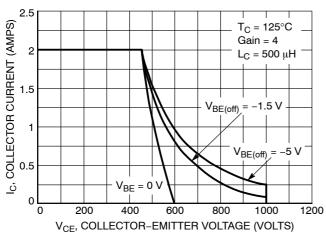


Figure 28. Reverse Bias Safe Operating Area

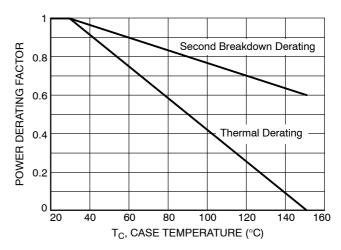


Figure 29. Forward Bias Power Derating

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate I_C – V_{CE} limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of Figure 27 is based on T_C = 25°C; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when T_C > 25°C. Second Breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on

Figure 27 may be found at any case temperature by using the appropriate curve on Figure 29.

T_{J(pk)} may be calculated from the data in Figure 30. At any case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn–off with the base to emitter junction reverse biased. The safe level is specified as a reverse biased safe operating area (Figure 28). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.

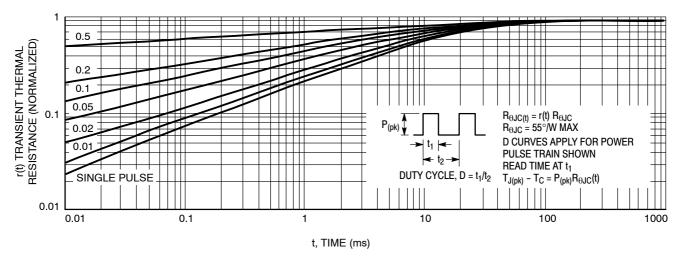


Figure 30. Typical Thermal Response ($Z_{\theta JC}(t)$) for MJD18002D2

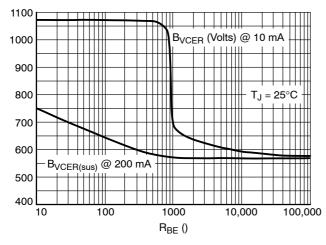


Figure 31. B_{VCER}

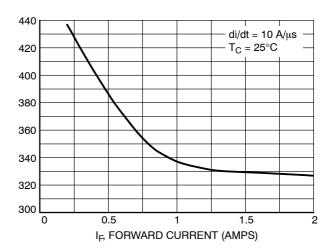
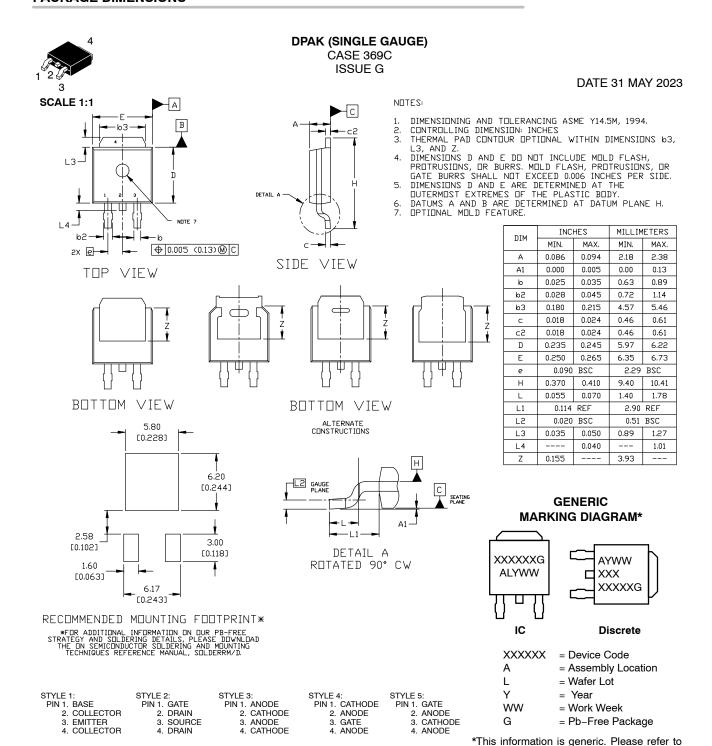


Figure 32. Forward Recovery Time, tfr





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DESCRIPTION:	DPAK (SINGLE GAUGE)		PAGE 1 OF 1		

STYLE 10:

PIN 1. CATHODE 2. ANODE

3 CATHODE

4. ANODE

STYLE 9:

PIN 1. ANODE 2. CATHODE

3 RESISTOR ADJUST

CATHODE

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STYLE 7: PIN 1. GATE 2. COLLECTOR

3 FMITTER

4. COLLECTOR

STYLE 8:

PIN 1. N/C 2. CATHODE

3 ANODE

CATHODE

STYLE 6:

PIN 1. MT1 2. MT2

3 GATE

device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot "■", may

or may not be present. Some products may

not follow the Generic Marking.

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